

# STL50NH3LL

N-channel 30 V - 0.011 Ω - 13 A - PowerFLAT™ (6x5) ultra low gate charge STripFET™ Power MOSFET

### Features

Туре	V <sub>DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>
STL50NH3LL	30V	<0.013Ω	13A <sup>(4)</sup>

- Improved die-to-footprint ratio
- Very low profile package (1 mm max)
- Very low thermal resistance
- Very low gate charge
- Low threshold device

### Applications

Switching application

### Description

This application specific Power MOSFET is the latest generation of STMicroelectronics unique "STripFET™" technology. The resulting transistor is optimized for low on-resistance and minimal gate charge. The Chip-scaled PowerFLAT™ package allows a significant board space saving, still boosting the performance.

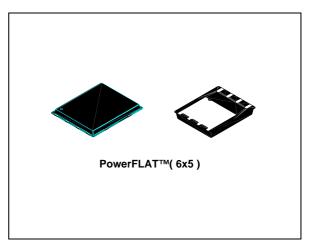


Figure 1. Internal schematic diagram

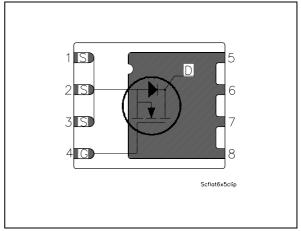


Table 1.	Device	summarv
	DEVICE	Summary

Order code	Marking	Package	Packaging
STL50NH3LL	L50NH3LL	PowerFLAT™ (6x5)	Tape & reel

## **Contents:**

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# 1 Electrical ratings

Table 2.	Absolute	maximum	ratings
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Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source voltage ( $V_{GS} = 0$ )	30	V
V <sub>GS</sub> <sup>(1)</sup>	Gate-source voltage	± 16	V
V <sub>GS</sub> <sup>(2)</sup>	Gate-source voltage	± 18	V
I <sub>D</sub> <sup>(3)</sup>	Drain current (continuous) at $T_C = 25^{\circ}C$	27	Α
I <sub>D</sub> <sup>(4)</sup>	Drain current (continuous) at T <sub>C</sub> =100°C	8.1	Α
I <sub>DM</sub> <sup>(5)</sup>	Drain current (pulsed)	108	Α
I <sub>D</sub> <sup>(4)</sup>	Drain current (continuous) at T <sub>C</sub> = 25°C	13	Α
P <sub>TOT</sub> <sup>(4)</sup>	Total dissipation at $T_{C} = 25^{\circ}C$	4	W
P <sub>TOT</sub> <sup>(3)</sup>	Total dissipation at $T_C = 25^{\circ}C$	60	W
	Derating factor	0.03	W/°C
T <sub>J</sub> T <sub>stg</sub>	Operating junction temperature Storage temperature	-55 to 150	°C

1. Continuous mode

2. Guaranteed for test time  $\leq$  15ms

3. The value is rated according  $\mathrm{R}_{\mathrm{thj-c}}$  and is limited by wire bonding

4. The value is rated according  $R_{thj-pcb}$ 

5. Pulse width limited by safe operating area

#### Table 3. Thermal resistance

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case (Drain)	2.08	°C/W
R <sub>thj-pcb</sub> <sup>(1)</sup>	Thermal resistance junction-ambient	31.3	°C/W

1. When mounted on FR-4 board of 1inch<sup>2</sup>, 2oz Cu, t < 10sec

#### Table 4. Avalanche data

Symbol	Parameter	Value	Unit
I <sub>AV</sub>	Not-repetitive avalanche current	7.5	А
E <sub>AS</sub>	Single pulse avalanche energy (starting Tj=25°C, Id=lav)	150	mJ

# 2 Electrical characteristics

(T<sub>CASE</sub>=25°C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$I_{D} = 25 0 \mu A, V_{GS} = 0$	30			V
I <sub>DSS</sub>	Zero gate voltage drain current ( $V_{GS} = 0$ )	V <sub>DS</sub> = Max rating, V <sub>DS</sub> = Max rating @125°C			1 10	μΑ μΑ
I <sub>GSS</sub>	Gate body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ±16 V			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$	1			V
R <sub>DS(on)</sub>	Static drain-source on resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 6.5 A V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 6. 5A		0.011 0.012	0.013 0.015	Ω Ω

#### Table 5. On/off states

#### Table 6. Dynamic

	<b>2 j</b>					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 <sub>fs</sub> <sup>(1)</sup>	Forward transconductance	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 6.5 \text{ A}$		32		S
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	V <sub>DS</sub> =25 V, f=1 MHz, V <sub>GS</sub> =0		965 285 38		pF pF pF
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	V <sub>DD</sub> =15 V, I <sub>D</sub> = 13 A V <sub>GS</sub> =4.5 V (see Figure 8)		9 3.7 3	12	nC nC nC
R <sub>G</sub>	Gate input resistance	f=1 MHz gate DC bias = 0 test signal level = 20 mV open drain	0.5	1.5	2.5	Ω

1. Pulsed: pulse duration=300 µs, duty cycle 1.5%



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub>	Turn-on delay time Rise time Turn-off delay time Fall time	$V_{DD}$ =15 V, I <sub>D</sub> = 6.5 A, R <sub>G</sub> =4.7 $\Omega$ , V <sub>GS</sub> =4.5 V (see Figure 14)		15 32 18 8.5		ns ns ns ns

Table 7.Switching times

#### Table 8. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
I <sub>SD</sub>	Source-drain current				13	А
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)				52	А
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	I <sub>SD</sub> =13 A, V <sub>GS</sub> =0			1.3	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	I <sub>SD</sub> =13 A, di/dt = 100 A/μs, V <sub>DD</sub> =20 V, Tj=150 °C (see Figure 16)		24 17.4 1.45		ns nC A

1. Pulse width limited by safe operating area

2. Pulsed: pulse duration=300  $\mu s,$  duty cycle 1.5%



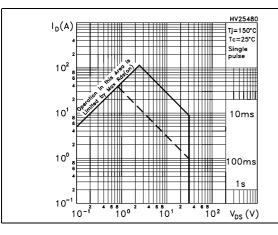
ZTH\_PFlat6x5

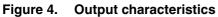
 $Z_{th} = k R_{thJ}$  $\delta = t_p / \tau$ 

10<sup>1</sup> tp(s)

### 2.1 Electrical characteristics (curves)

#### Figure 2. Safe operating area





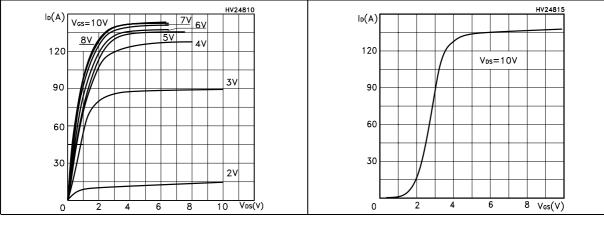


Figure 3.

10

10

10

10

10-5

Figure 5.

 $\delta = 0.5$ 

0.2

0.1

0.05

0.02

0.01

10-4

**Thermal impedance** 

SINGLE PULSE

10<sup>-2</sup>

**Transfer characteristics** 

10-1

100

10-3



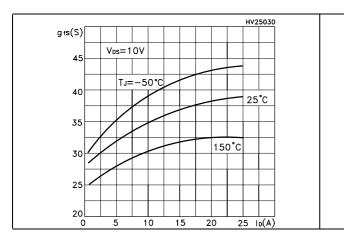
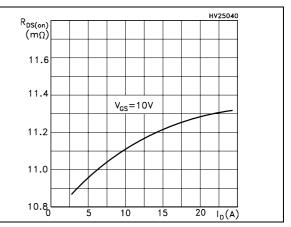


Figure 7. Static drain-source on resistance





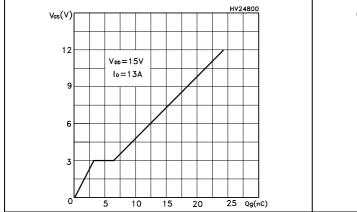


Figure 8. Gate charge vs. gate-source voltage Figure 9. Capacitance variations

Figure 10. Normalized gate threshold voltage vs. temperature

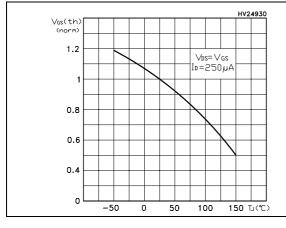


Figure 12. Source-drain diode forward characteristics

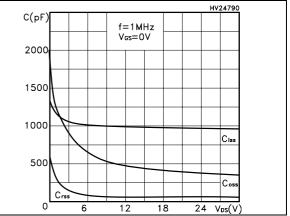


Figure 11. Normalized on resistance vs. temperature

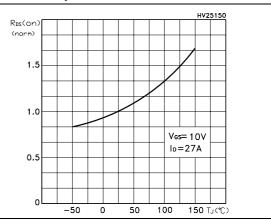
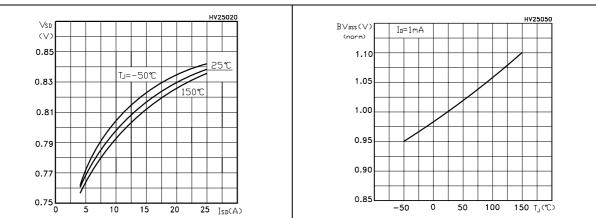


Figure 13. Normalized B<sub>VDSS</sub> vs. temperature



57

## 3 Test circuit

Figure 14. Switching times test circuit for resistive load

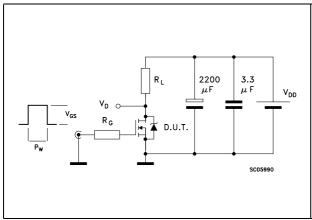
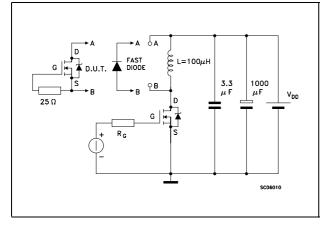


Figure 16. Test circuit for inductive load switching and diode recovery times





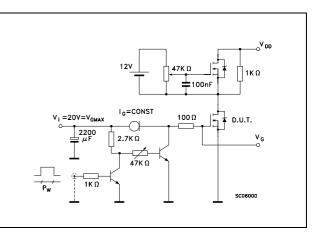


Figure 15. Gate charge test circuit

Figure 17. Unclamped inductive load test circuit

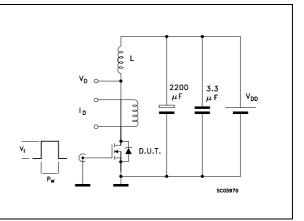
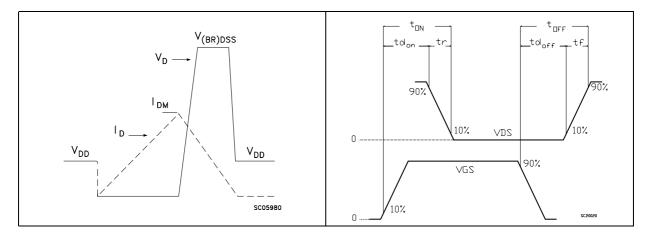


Figure 19. Switching time waveform



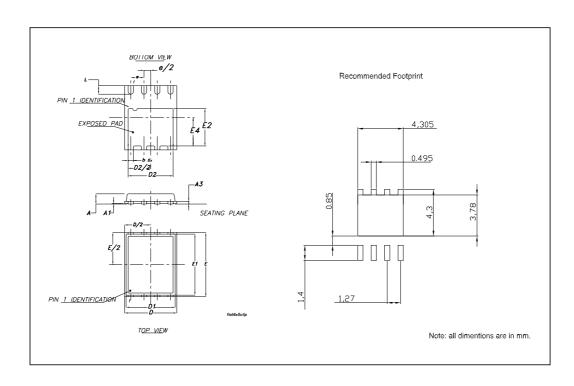
### 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com



DIM.	mm.			inch		
	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
А	0.80	0.83	0.93	0.031	0.032	0.036
A1		0.02	0.05		0.0007	0.0019
A3		0.20			0.007	
b	0.35	0.40	0.47	0.013	0.015	0.018
D		5.00			0.196	
D1		4.75			0.187	
D2	4.15	4.20	4.25	0.163	0.165	0.167
E		6.00			0.236	
E1		5.75			0.226	
E2	3.43	3.48	3.53	0.135	0.137	0.139
E4	2.58	2.63	2.68		0.103	0.105
е		1.27			0.050	
L	0.70	0.80	0.90	0.027	0.031	0.035

#### PowerFLAT™ (6x5) MECHANICAL DATA



# 5 Revision history

Table 9. Revision history	Table 9.	<b>Revision history</b>	
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Date	Revision	Changes
21-Jul-2005	1	First Release
14-Apr-2005	2	Final version
20-Jun-2005	3	Updated mechanical data
22-Jun-2005	4	New Rg value on Table 7
30-Sep-2005	5	Inserted ecopack indication
04-Jan-2006	6	New footprint
30-Mar-2006	7	New template
27-Jul-2006	8	Updated Figure 2
06-Sep-2006	9	New template, no content change
11-Dec-2007	10	Updated E <sub>AS</sub> value on <i>Table 4: Avalanche data</i>

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